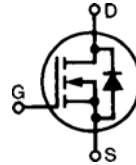


# HiPerFET™ Power MOSFETs

N-Channel Enhancement Mode  
High dv/dt, Low t<sub>rr</sub>, HDMOS™ Family

**Obsolete:**  
IXFM10N90  
IXFM12N90

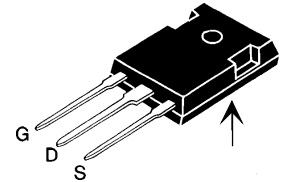
~~IXFH/IXFM 10 N90~~  
~~IXFH/IXFM 12 N90~~  
IXFH/IXFT 13 N90



V <sub>DSS</sub>	I <sub>D25</sub>	R <sub>DS(on)</sub>
900 V	10 A	1.1 Ω
900 V	12 A	0.9 Ω
900 V	13 A	0.8 Ω

t<sub>rr</sub> ≤ 250 ns

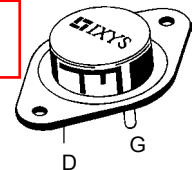
TO-247 AD (IXFH)



(TAB)

~~TO-204 AA (IXFM)~~

Package  
unavailable



TO-268 (IXFT)



G = Gate, D = Drain,  
S = Source, TAB = Drain

Symbol	Test Conditions	Maximum Ratings	
V <sub>DSS</sub>	T <sub>J</sub> = 25°C to 150°C	900	V
V <sub>DGR</sub>	T <sub>J</sub> = 25°C to 150°C; R <sub>GS</sub> = 1 MΩ	900	V
V <sub>GS</sub>	Continuous	±20	V
V <sub>GSM</sub>	Transient	±30	V
I <sub>D25</sub>	T <sub>C</sub> = 25°C	10N90 10 12N90 12 13N90 13	A
I <sub>DM</sub>	T <sub>C</sub> = 25°C, pulse width limited by T <sub>JM</sub>	10N90 40 12N90 48 13N90 52	A
I <sub>AR</sub>	T <sub>C</sub> = 25°C	10N90 10 12N90 12 13N90 13	A
E <sub>AR</sub>	T <sub>C</sub> = 25°C	30	mJ
dv/dt	I <sub>S</sub> ≤ I <sub>DM</sub> , di/dt ≤ 100 A/μs, V <sub>DD</sub> ≤ V <sub>DSS</sub> , T <sub>J</sub> ≤ 150°C, R <sub>G</sub> = 2 Ω	5	V/ns
P <sub>D</sub>	T <sub>C</sub> = 25°C	300	W
T <sub>J</sub>		-55 ... +150	°C
T <sub>JM</sub>		150	°C
T <sub>stg</sub>		-55 ... +150	°C
T <sub>L</sub>	1.6 mm (0.062 in.) from case for 10 s	300	°C
M <sub>d</sub>	Mounting torque	1.13/10	Nm/lb.in.
Weight		TO-204 = 18 g, TO-247 = 6 g	

### Features

- International standard packages
- Low R<sub>DS(on)</sub> HDMOS™ process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance  
- easy to drive and to protect
- Fast intrinsic Rectifier

### Applications

- DC-DC converters
- Synchronous rectification
- Battery chargers
- Switched-mode and resonant-mode power supplies
- DC choppers
- AC motor control
- Temperature and lighting controls
- Low voltage relays

### Advantages

- Easy to mount with 1 screw (TO-247) (isolated mounting screw hole)
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values (T <sub>J</sub> = 25°C, unless otherwise specified)		
		min.	typ.	max.
V <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 3 mA	900		V
V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>DSS</sub> , I <sub>D</sub> = 4 mA	2.0		4.5 V
I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V <sub>DC</sub> , V <sub>DS</sub> = 0			±100 nA
I <sub>DSS</sub>	V <sub>DS</sub> = V <sub>DSS</sub> , V <sub>GS</sub> = 0 V			25 μA 1 mA (T <sub>J</sub> = 125°C)
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5 • I <sub>D25</sub>	10N90 12N90 13N90		1.1 Ω 0.9 Ω 0.8 Ω
	Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %			

**Symbol Test Conditions**

**Characteristic Values**

( $T_J = 25^\circ\text{C}$ , unless otherwise specified)

		min.	typ.	max.
$g_{fs}$	$V_{DS} = 10\text{ V}; I_D = 0.5 \cdot I_{D25}$ , pulse test	6	12	S
$C_{iss}$	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	4200		pF
$C_{oss}$		315		pF
$C_{rss}$		90		pF
$t_{d(on)}$	$V_{GS} = 10\text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 0.5 \cdot I_{D25}$ $R_G = 2\ \Omega$ (External)	18	50	ns
$t_r$		12	50	ns
$t_{d(off)}$		51	100	ns
$t_f$		18	50	ns
$Q_{g(on)}$	$V_{GS} = 10\text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 0.5 \cdot I_{D25}$	123	155	nC
$Q_{gs}$		27	45	nC
$Q_{gd}$		49	80	nC
$R_{thJC}$	(IXFH/IXFM)	0.42		K/W
$R_{thCK}$		0.25		K/W

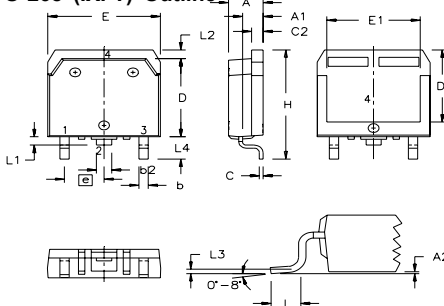
**Source-Drain Diode**

**Characteristic Values**

( $T_J = 25^\circ\text{C}$ , unless otherwise specified)

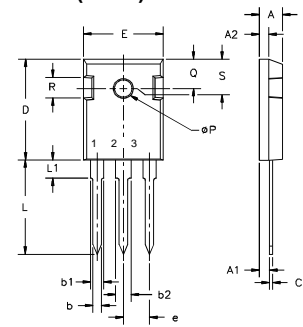
Symbol	Test Conditions			
		min.	typ.	max.
$I_S$	$V_{GS} = 0\text{ V}$	10N90 12N90 13N90		10 A 12 A 13 A
$I_{SM}$	Repetitive; pulse width limited by $T_{JM}$	10N90 12N90 13N90		40 A 48 A 52 A
$V_{SD}$	$I_F = I_S, V_{GS} = 0\text{ V}$ , Pulse test, $t \leq 300\ \mu\text{s}$ , duty cycle $d \leq 2\%$			1.5 V
$t_{rr}$	$I_F = I_S$ $-di/dt = 100\text{ A}/\mu\text{s}$ , $V_R = 100\text{ V}$	$T_J = 25^\circ\text{C}$		250 ns
$Q_{RM}$		$T_J = 125^\circ\text{C}$	1	$\mu\text{C}$
		$T_J = 125^\circ\text{C}$	2	$\mu\text{C}$
$I_{RM}$		$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	10 15	A A

**TO-268 (IXFT) Outline**



SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.193	.201	4.90	5.10
A1	.106	.114	2.70	2.90
A2	.001	.010	0.02	0.25
b	.045	.057	1.15	1.45
b2	.075	.083	1.90	2.10
C	.016	.026	0.40	0.65
C2	.057	.063	1.45	1.60
D	.543	.551	13.80	14.00
D1	.488	.500	12.40	12.70
E	.624	.632	15.85	16.05
E1	.524	.535	13.30	13.60
e	.215 BSC 5.45 BSC			
H	.736	.752	18.70	19.10
L1	.094	.106	2.40	2.70
L2	.047	.055	1.20	1.40
L3	.039	.045	1.00	1.15
L4	.010 BSC 0.25 BSC			
L4	.150	.161	3.80	4.10

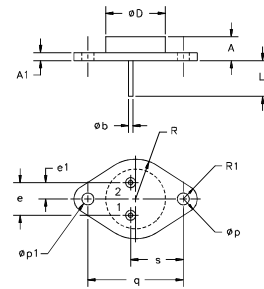
**TO-247 AD (IXFH) Outline**



Terminals: 1 - Gate    2 - Drain  
3 - Source    Tab - Drain

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.7	5.3	.185	.209
A <sub>1</sub>	2.2	2.54	.087	.102
A <sub>2</sub>	2.2	2.6	.059	.098
b	1.0	1.4	.040	.055
b <sub>1</sub>	1.65	2.13	.065	.084
b <sub>2</sub>	2.87	3.12	.113	.123
C	.4	.8	.016	.031
D	20.80	21.46	.819	.845
E	15.75	16.26	.610	.640
e	5.20	5.72	0.205	0.225
L	19.81	20.32	.780	.800
L <sub>1</sub>	4.50		.177	
∅P	3.55	3.65	.140	.144
Q	5.89	6.40	0.232	0.252
R	4.32	5.49	.170	.216
S	6.15 BSC		242 BSC	

**TO-204 AA (IXFM) Outline**



Pins 1 - Gate    2 - Source  
Case - Drain

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	6.4	11.4	.250	.450
A1	3.42		.135	
∅b	.97	1.09	.038	.043
∅D	22.22		.875	
e	10.67	11.17	.420	.440
e1	5.21	5.71	.205	.225
L	7.93		.312	
∅p	3.84	4.19	.151	.165
∅p1	3.84	4.19	.151	.165
q	30.15 BSC		1.187 BSC	
R	13.33		.525	
R1	4.77		.188	
s	16.64	17.14	.655	.675

IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

4,835,592    4,881,106    5,017,508  
4,850,072    4,931,844    5,034,796

5,049,961    5,187,117    5,486,715    6,306,728B1  
5,063,307    5,237,481    5,381,025

Fig. 1. Output Characteristics

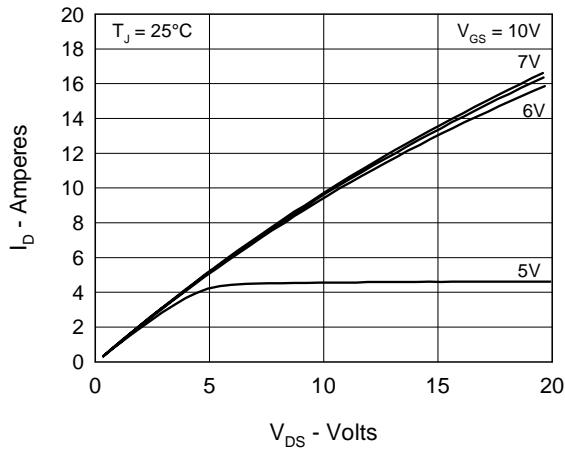


Fig. 2. Input Admittance

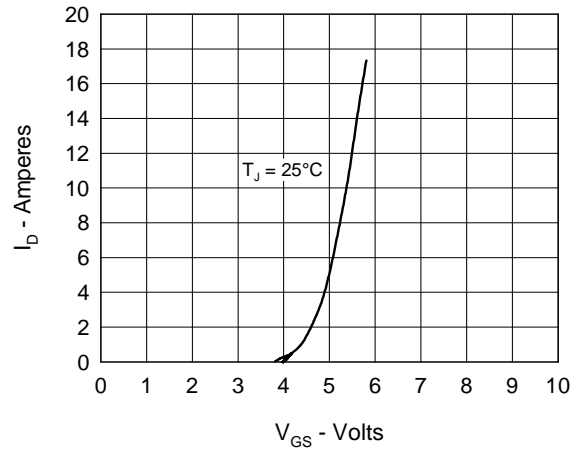


Fig. 3.  $R_{DS(on)}$  vs. Drain Current

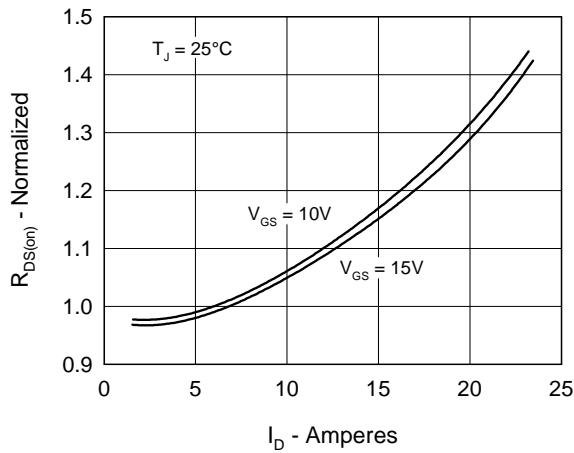


Fig. 4. Temperature Dependence of Drain to Source Resistance

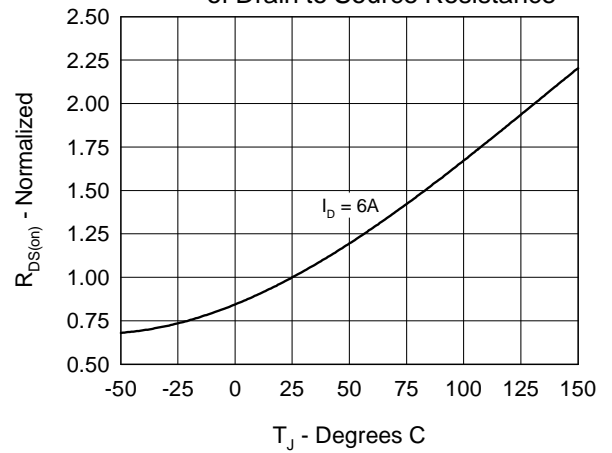


Fig. 5. Drain Current vs. Case Temperature

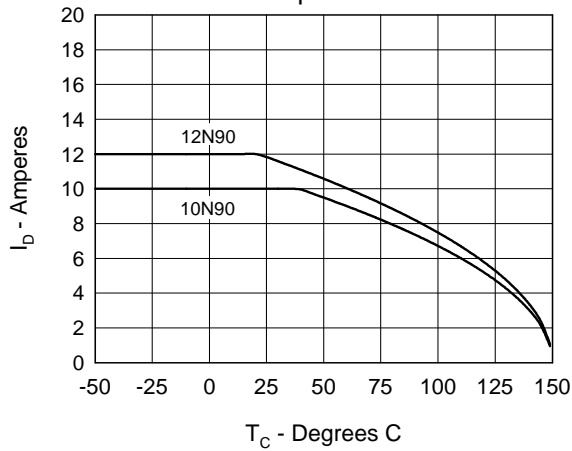


Fig. 6. Temperature Dependence of Breakdown and Threshold Voltage

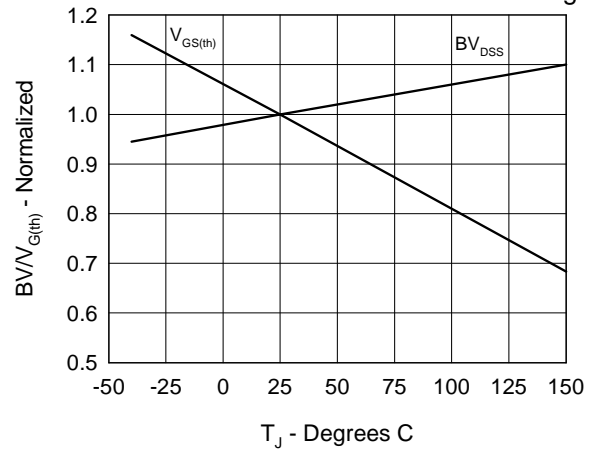


Fig.7. Gate Charge Characteristic Curve

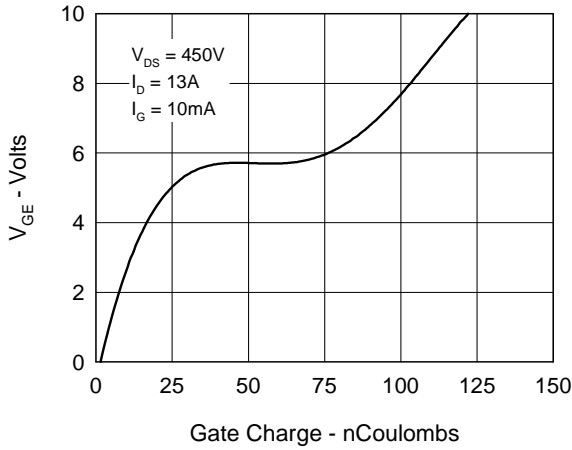


Fig.8. Capacitance Curves

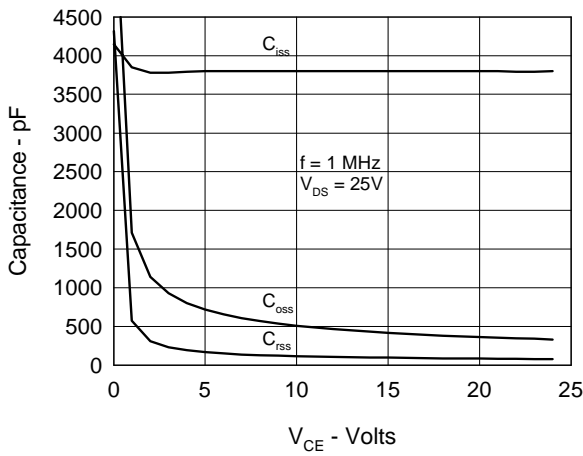


Fig.9. Source Current vs. Source to Drain Voltage

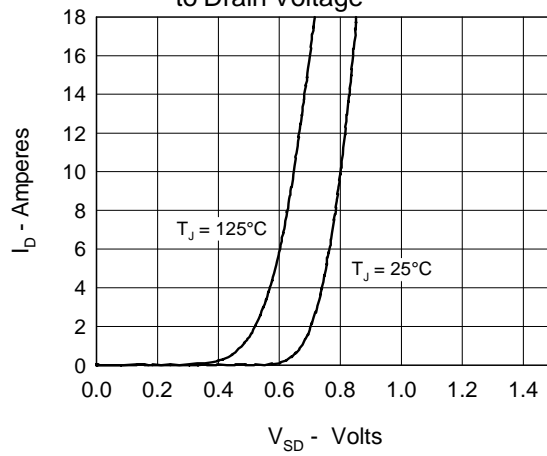
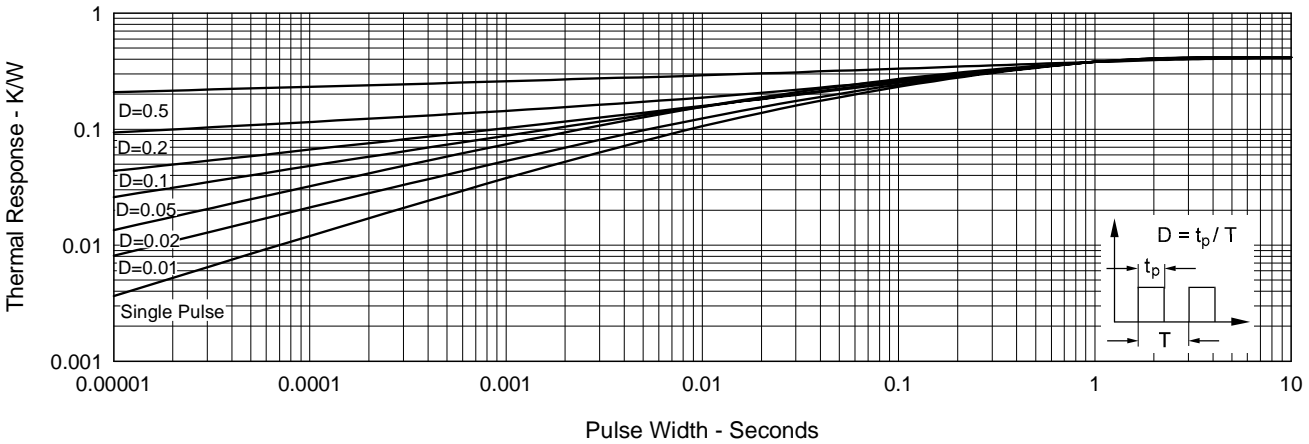


Fig.10. Transient Thermal Impedance



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